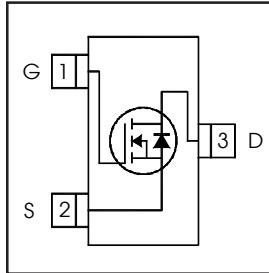


# IRLML6246TRPbF

## HEXFET® Power MOSFET

<b>V<sub>DS</sub></b>	<b>20</b>	<b>V</b>
<b>V<sub>GS Max</sub></b>	<b>± 12</b>	<b>V</b>
<b>R<sub>DS(on)</sub> max (@V<sub>GS</sub> = 4.5V)</b>	<b>46</b>	<b>mΩ</b>
<b>R<sub>DS(on)</sub> max (@V<sub>GS</sub> = 2.5V)</b>	<b>66</b>	<b>mΩ</b>



### Application(s)

- Load/ System Switch

### Features and Benefits

#### Features

Industry-standard SOT-23 Package	Multi-vendor compatibility
RoHS compliant containing no lead, no bromide and no halogen	results in Environmentally friendly

#### Benefits

### Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	4.1	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	3.3	
I <sub>DM</sub>	Pulsed Drain Current	16	W
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation	1.3	
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Maximum Power Dissipation	0.8	W/°C
	Linear Derating Factor	0.01	
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 150	°C

### Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJA</sub>	Junction-to-Ambient ③	—	100	°C/W
R <sub>θJA</sub>	Junction-to-Ambient (t<10s) ④	—	99	

**Electric Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.03	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	30	46	$\text{m}\Omega$	$V_{GS} = 4.5V, I_D = 4.1\text{A}$ $\textcircled{2}$
		—	45	66		$V_{GS} = 2.5V, I_D = 3.3\text{A}$ $\textcircled{2}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	0.5	0.8	1.1	V	$V_{DS} = V_{GS}, I_D = 5\mu\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$V_{DS} = 16V, V_{GS} = 0V$
		—	—	10		$V_{DS} = 16V, V_{GS} = 0V, T_J = 55^\circ\text{C}$
		—	—	150		$V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{GS} = 12V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -12V$
$R_G$	Internal Gate Resistance	—	4.0	—	$\Omega$	
$g_{fs}$	Forward Transconductance	10	—	—	S	$V_{DS} = 10V, I_D = 4.1\text{A}$
$Q_g$	Total Gate Charge	—	3.5	—	$\text{nC}$	$I_D = 4.1\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	0.26	—		$V_{DS} = 10V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	1.7	—		$V_{GS} = 4.5V$ $\textcircled{2}$
$t_{d(on)}$	Turn-On Delay Time	—	3.6	—	$\text{ns}$	$V_{DD} = 10V$ $\textcircled{2}$
$t_r$	Rise Time	—	4.9	—		$I_D = 1.0\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	11	—		$R_G = 6.8\Omega$
$t_f$	Fall Time	—	6.0	—		$V_{GS} = 4.5V$
$C_{iss}$	Input Capacitance	—	290	—	$\text{pF}$	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	64	—		$V_{DS} = 16V$
$C_{rss}$	Reverse Transfer Capacitance	—	41	—		$f = 1.0\text{MHz}$

**Source - Drain Ratings and Characteristics**

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	1.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) $\textcircled{1}$	—	—	16		
$V_{SD}$	Diode Forward Voltage	—	—	1.2	V	$T_J = 25^\circ\text{C}, I_S = 4.1\text{A}, V_{GS} = 0V$ $\textcircled{2}$
$t_{rr}$	Reverse Recovery Time	—	8.6	13	ns	$T_J = 25^\circ\text{C}, V_R = 15V, I_F = 1.3\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	2.8	4.2	nC	$dI/dt = 100\text{A}/\mu\text{s}$ $\textcircled{2}$